

<b>Notice of References Cited</b>	Application/Control No. 10/801,540	Applicant(s)/Patent Under Reexamination HOUCK ET AL.	
	Examiner Pedro J. Cuevas	Art Unit 2834	Page 1 of 4

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<b>Notice of References Cited</b>	Application/Control No. 10/801,540		Applicant(s)/Patent Under Reexamination HOUCK ET AL.	
	Examiner Pedro J. Cuevas		Art Unit 2834	Page 2 of 4

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Application/Control No.

10/801,540

Applicant(s)/Patent Under  
Reexamination  
HOUCK ET AL.

Examiner

Pedro J. Cuevas

Art Unit

2834

Page 3 of 4

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HOUCK ET AL.

Examiner

Pedro J. Cuevas

Art Unit

2834

Page 4 of 4

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